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Application No.	Applicant(s)	
10/066,456	TEIG ET AL.	
Examiner	Art Unit	
Binh C. Tat	2825	

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SEARCHED				
Class	Subclass	Date	Examiner	
716	1-18	7/25/2004	вт	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			)
		DATE	EXMR
EAST SEARCH		7/25/2004	ВТ
IEEE		7/25/2004	ВТ